

Cooled qVGA SWIR InGaAs Camera



Quantitative SWIR imaging and spectroscopy

The camera uses selected InGaAs focal plane arrays with low dark current and low defective pixel count.

Thanks to efficient cooling and stable offset, the InGaAs camera allows reproducible acquisition for precise metrology measurements in the SWIR spectrum.

Camera Link and Gigabit Ethernet Vision compliant interface enables easy integration into existing systems. InGaAs sensors with 320 x 256 resolution are also available with extended spectral response up to 2.2 μ m.

OEM versions with special form factors / cooling options are available for integration into specific instruments / systems.

Applications

Available with passive cooling

- Semiconductor inspection
- SWIR handheld vision enhancement
- SWIR airborne payload
- Photoluminescence for solar cells

Key Features

- | 14-bit digitization / 16-bit image processing
- | Read out noise
down to typically <120 electrons
- | >100 fps
full resolution with region of interest ROI
- | Excellent linearity
response to varying intensities and / or exposures
- | Gigabit Ethernet & Camera Link interface
- | Software option:
SDK kit, Labview VI's

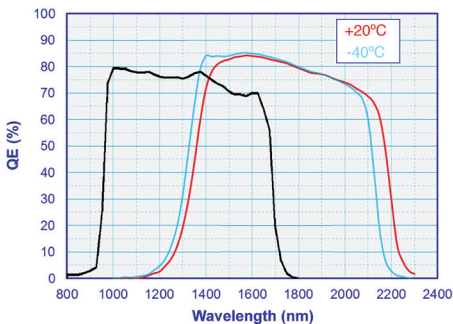
Air cooling or water cooling for long exposure

- Astronomy
- Hyperspectral imaging
- Laser beam profiling
- Spectroscopy

Cooled qVGA SWIR InGaAs Camera

| Characteristics | PSEL qVGA 30 μ m |
|-------------------------|---|
| Spectral Range | 900 - 1700 nm |
| Resolution | 320 x 256 |
| Sensor Size | 9.6 mm x 7.68 mm |
| Frame Rate | 110 fps at full qVGA resolution |
| Pitch | 30 μ m x 30 μ m |
| Full Well Capacity | 110k - 150k electrons (high gain mode) 1.5M - 2.2M electrons (low gain mode) |
| Read Out Noise | 110 - 200 electrons (high gain mode) 1000 - 1590 electrons (low gain mode) |
| Reading Mode | Integrate Then Read, Integrate While Read |
| Dark Current | <8fA with air cooling & <0.5fA with water cooling |
| Sensor Temperature (°C) | -20°C with air cooling, -40°C with water cooling (lower dark current) |
| Corrections | Non uniformity, bright pixel, gain, offset, flatfield |
| ADC | 14-bit with 16-bit digital processing |
| Exposure | 1 microsecond up to > 1 second |
| QE at 1500 nm | 80% |

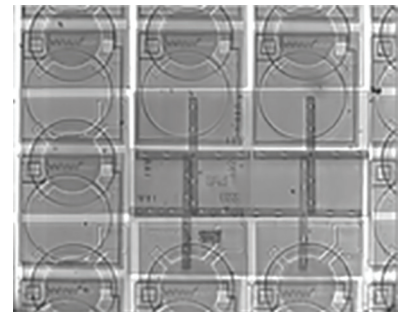
Quantum Efficiency



Quantum efficiency response of Cooled SWIR InGaAs camera



Photoemission microscopy on IC using water cooled SWIR InGaAs camera, with 20x objective, exposure time 30s



Transmission infrared microscopy of MEMS wafers using SWIR InGaAs camera with 6x objective, exposure time 15ms